Issue Classification	Application/Control No.	Applicant(s)/Patent Under Reexamination
[barcode]	09837389	GARVEY ET AL.
	Examiner	Art Unit
	Nano, Sargon N	2157

ORIGINAL		INTERNATIONAL CLASSIFICATION			
CLASS	**SUBCLASS**	**CLAIMED**		**NON-CLAIMED**	
709	223	G 0 6 F	15 / 173	G 0 6 F	15 / 16

CROSS REFERENCE(S)

CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
709	208				

Nano, Sargon N	4/30/2007		Total Claims Allowed:	
(Assistant Examiner)	(Date)	ERIC ETIENNE	13	
		SUPERVISORY PATENT EXAMINER		
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(Legal Instruments Examiner)	(Date)	(Primary Examiner) (Date) 6/4/07	1	2A

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